

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

NATSUNO, TAKESHI

Examiner

EDWYN LABAZE

Art Unit

2876

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,541,985 ✓	07-1996	Ishii et al.	379/111
	B	US-5,850,440 ✓	12-1998	Hannon et al.	379/446
	C	US-6,035,216 ✓	03-2000	Cheng et al.	455/558
	D	US-6,142,369 ✓	11-2000	Jonstromer, Ulf	235/380
	E	US-6,164,989 ✓	12-2000	Glad et al.	439/131
	F	US-6,170,745 ✓	01-2001	Schilling, Donald L.	235/382.5
	G	US-6,259,409 ✓	07-2001	Fulton et al.	343/702
	H	US-6,454,164 ✓	09-2002	Wakabayashi et al.	235/380
	I	US-5,809,432 ✓	09-1998	Yamashita, Osamu	455/575.1
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

*		
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	W	
	X	

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